

Search Notes

Application/Control No.

09/382,375

Examiner

Hai V. Nguyen

Applicant(s)/Patent under
Reexamination

PHILYAW ET AL.

Art Unit

2142

SEARCHED

Class	Subclass	Date	Examiner
709	220	11/22/2005	HN
709	224	11/22/2005	HN
707	5	11/22/2005	HN
705	52	11/22/2005	HN
235	383	11/22/2005	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search Updated	11/22/2005	HN
Consult with Thong Vu (AU 2142)	11/22/2005	HN